



ENGINEERING DEPT.

PRODUCT SPECIFICATION

SPEC.NO.: SPCI117B

REVISIONS | ECNT120150

For CI16 Series Connector System

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1. SCOPE:

This specification contains the test requirement of subject connectors when tested under the condition and procedure with terminals crimped on the specified maximum size wire

2. APPLICABLE STANDARDS:

MIL - STD - 202

Methods for test of connectors for electronic equipment

EIA - 364

Test methods for electrical connectors

3. APPLICABLE SERIES NO: CI16 Series

4. SHAPE, CONSTRUCTION AND DIMENSIONS

See attached drawings

5. MATERIALS

See attached drawings

6. ACCOMMODATED P.C.BOARD

6.1 Thickness: $0.6 \text{ mm} (.024'') \sim 1.2 \text{ mm} (.047''), 1.6 \text{mm} (.063'')$

6.2 P.C. Board Layout: See attached drawings

REVIEWED: Eisley APPROVED: Sun VERIFIED: Michelle.





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7. ELECTRICAL PERFORMANCE:

	ITEM	TEST CONDITION	REQUIREMENT
7.1	Rated current and voltage		1.0A AC (r.m.s.)/DC
			(AWG#28)
			125V AC (r.m.s.)/DC
7.2	Contact resistance	Dry circuit of DC 20 mV max., 100 mA max.(JIS C5402 5.4)	Less than $20 \text{ m}\Omega$
7.3	Dielectric strength	When applied AC 500 V 1 minute between adjacent terminal(JIS C5402 5.2/MIL-STD 202 method 302 Cond. B)	No change
7.4	Insulation resistance	When applied DC 500 V between adjacent terminal or ground (JIS C5402 5.2/MIL-STD 202 method 301)	More than 100 MΩ

8. MECHANICAL PERFORMANCE:

	ITEM	TEST CONDITION	REQUIREMENT
8.1	Wire size	Specified wire size	Accepts AWG#28~#32
8.2	Terminal crimp Tensile When crimped AWG#28 size wire		More than 1.3 Kgf
	strength	When crimped AWG#30 size wire	More than 0.8 Kgf
		When crimped AWG#32 size wire	More than 0.6 Kgf
8.3	Terminal insertion force in insulator	Insertion speed 25± 3 mm per minute into housing	Less than 0.60 Kgf
8.4	Terminal retaining force in insulator	Retention speed 25± 3 mm per minute from housing	More than 0.60 Kgf
8.5	Pin retention force	Push pin from insulator base at speed	More than 0.30 Kgf
		25± 3 mm per minute	
8.6	Mating & Un-mating force	Insert and withdraw connector at speed of 25 ± 3 mm per minute	See Item 11
8.7			2P
		terminal at speed 25±3 mm per minute	More than 1.5 Kgf
			3P~6P:
			More than 2 Kgf
			7P~20P:
			More than 3 Kgf





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	ITEM	TEST CONDITION	REQUIREMENT
8.8	Durability	Connector shall be subjected to 30 cycles of insertion and withdrawal (repeatedly by the rate of 10 cycles per minute)	Contact resistance: Less than twice of initial
8.9		The product should match three requirements after 5 cycles of insertion and withdrawal (mating and un-mating) test. We will withdrawal the housing by pulling the wire toward four directions to left, right, up and down at maximum angel of 60° for 5 times.	Contact resistance: Less than 1.5 times of the initial value. Temperature rise: 30°C max. The dimension of the open window of plug contact on wafer side should be less than 0.39mm.

9. ENVIRONMENTAL PERFORMANCE:

	ITEM	TEST CONDITION	REQUIREMENT
9.1	Temperature rise	Then carried the rated current (UL 498)	30°C max.
9.2	Vibration	1.5 mm 10-55-10 HZ / minute each 2 hours for X, Y and Z directions (MIL-STD-202,method 201A)	Appearance: No damage Discontinuity: 1 micro second max.
9.3	Solder ability	Lead-Free Process for SMT Type: Soldering time: 3 ± 0.5 second Soldering pot: 245 ± 5 °C	Minimum: 90% of immersed area
9.4	Resistance to soldering heat	Refer Reflow temperature profile	No damage
9.5	Heat aging	85 ± 2°C , 96 hours(JIS C0021/MIL-STD-202,method 108A,condition A)	No damage Contact resistance: Less than twice of initial
9.6	Humidity	$60\pm2^{\circ}\text{C}$, 90-95% RH , 96 hours measurement must be taken within 30 min. after tested (JIS C0020/MIL-STD-202, method 103 B, condition B)	Appearance: No damage Contact resistance: Less than twice of initial Insulation resistance: To pass Para 7-4





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	ITEM	TEST CONDITION	REQUIREMENT
9.7	Temperature cycling	Five cycle consists of :(JIS C0025)	Appearance: No damage
		(1) $-55 + 0 \circ C$, 30 min.	Contact resistance:
		(2)Room temp. 10-15 min.	Less than twice of initial
		(3) $85^{+3} {}^{\circ}C$, 30 min.	
		(4)Room temp. 10-15 min.	
9.8	Salt spray	Temperature: 35 ± 3 °C	Appearance: No damage
		Solution: 5 ± 1%	Contact resistance:
		Spray time: 48 ± 4 hours	Less than twice of initial
		(Stamping before plated)	
		Spray time: 24 ± 4 hours	
		(Stamping after plated)	
		Mate connectors and expose to the following salt mist conditions. Upon completion of the exposure period, salt deposits shall be removed by a gentle wash or dip in running water and dried naturally, after which the specified measurements shall be performed.	
		The specimens shall be suspended from the top using waxed twine, string or nylon thread.	
		The test only define the plating area, without plating area (as copper cross section) will not be defined.	
		(EIA 364-26B / MIL-STD-202 Method 101)	

10. AMBIENT TEMPERATURE RANGE: -25 to +85°C





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11. Mating and Un-mating Force(Remove Latch):

DIM N.	At Initial		At 30th
PIN No.	Mating(kgf max.)	Un-mating(kfg min.)	Un-mating(kfg min.)
2	2.00	0.20	0.20
3	2.00	0.20	0.20
4	2.00	0.20	0.20
5	3.00	0.30	0.30
6	3.00	0.30	0.30
7	3.00	0.30	0.30
8	4.00	0.40	0.40
9	4.00	0.40	0.40
10	4.00	0.40	0.40
11	5.00	0.50	0.50
12	5.00	0.50	0.50
13	5.00	0.50	0.50
14	6.00	0.60	0.60
15	6.00	0.60	0.60
16	6.00	0.60	0.60
17	7.00	0.70	0.70
18	7.00	0.70	0.70
19	7.00	0.70	0.70
20	8.00	0.80	0.80





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12. Recommended IR Reflow Temperature Profile:

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12.1 Using Lead-Free Solder Paste

